Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination NAKAYAMA ET AL.	
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Examiner	Art Unit	
Khiem D. Nguyen	2823	

SEARCHED					
Class	Subclass	Date	Examiner		
438	478	2/25/2005	k'h'		
438	485	2/25/2005	K.N.		
438	486	2/25/2005	K.n.		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
438	478	2/25/2005	K.N.		
438	485	2/25/2005	K.N.		
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EAST (updated search)	2/25/2005	K.N.